



# P24C128D

## I<sup>2</sup>C-Compatible Serial E<sup>2</sup>PROM

### Datasheet V1.7

## General Description

The P24C128D is I<sup>2</sup>C-compatible Serial EEPROM (Electrically Erasable Programmable Memory) device. It contains a memory array of 128 Kbits (16 Kbytes), which is organized in 64 bytes per page.

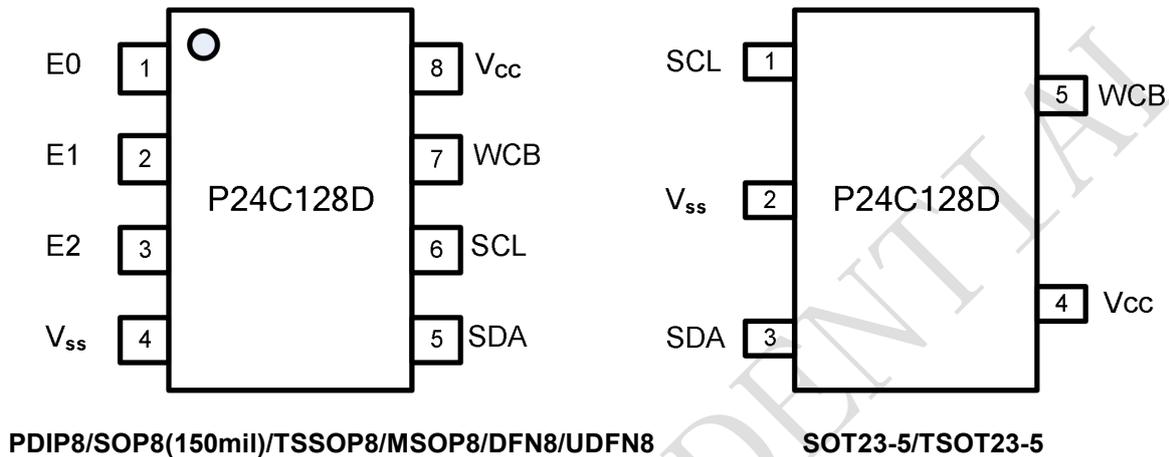
## Features

- Single Supply Voltage and High Speed Mode
  - ◇ Minimum operating voltage down to 1.7 V
  - ◇ 400 kHz/1 MHz clock from 1.7 V to 5.5 V
- Low power CMOS technology
  - ◇ Read current 0.2 mA (400 kHz, typical)
  - ◇ Write current 0.8 mA (400 kHz, typical)
- Schmitt Trigger, Filtered Inputs for Noise Suppression
- Sequential & Random Read Features
- Page Write Modes, Partial Page Writes Allowed
- Write protection of the whole memory array
- Additional Write Lockable Page and 128 bits Serial Number
- Self-timed Write Cycle (5 ms maximum)
- High Reliability
  - ◇ Endurance: 1 Million Write Cycles
  - ◇ Data Retention: 100 Years
  - ◇ ESD Protection (HBM): 6 kV
  - ◇ Latch up Capability: +/- 200 mA (25 C)
- Package:
  - ◇ PDIP8, SOP8(150mil), TSSOP8, MSOP8,DFN8/UDFN8, SOT23-5, TSOT23-5

## 1. Pin Configuration

### 1.1 Pin Configuration

Figure 1-1 Pin Configuration



### 1.2 Pin Definition

Table 1-1 Pin Definition for PDIP8/SOP8/TSSOP8/DFN8/MSOP8 Packages

Pin	Name	Type	Description
1	E0	Input	Slave Address Setting
2	E1	Input	Slave Address Setting
3	E2	Input	Slave Address Setting
4	Vss	Ground	Ground
5	SDA	I/O	Serial Data Input and Serial Data Output
6	SCL	Input	Serial Clock Input
7	WCB	Input	Write Control, Low Enable Write
8	Vcc	Power	Power Supply

Table 1-2 Pin Definition for SOT23-5/TSOT23-5 Packages

Pin	Name	Type	Description
1	SCL	Input	Serial Clock Input
2	Vss	Ground	Ground
3	SDA	I/O	Serial Data Input and Serial Data Output
4	Vcc	Power	Power Supply
5	WCB	Input	Write Control, Low Enable Write

### 1.3 Pin Descriptions

**Serial Clock (SCL):** The SCL input is used to clock in data at positive edge and clock out data from EEPROM at negative edge.

**Serial Data (SDA):** The SDA pin is bidirectional for serial data transfer. This pin is open drain driven and may be wired-OR'ed with any number of other open-drain or open-collector devices.

**Device Addresses (E2, E1, E0):** The E2, E1 and E0 pins are device address inputs. Typically, the E2, E1 and E0 pins are for hardware addressing and a total of 8 devices can be connected on a single bus system. If these pins are left floating, the E2, E1 and E0 pins will be internally pulled down to  $V_{ss}$ , and the corresponding device address is fixed to 0.

**Write Control (WCB):** The Write Control input, when WCB is connected directly to  $V_{cc}$ , all write operations to the memory are inhibited. When connected to  $V_{ss}$ , allows normal write operations. If the pin is left floating, the WCB pin will be internally pulled down to  $V_{ss}$ .

**Supply Voltage ( $V_{cc}$ ):**  $V_{cc}$  is the supply voltage.

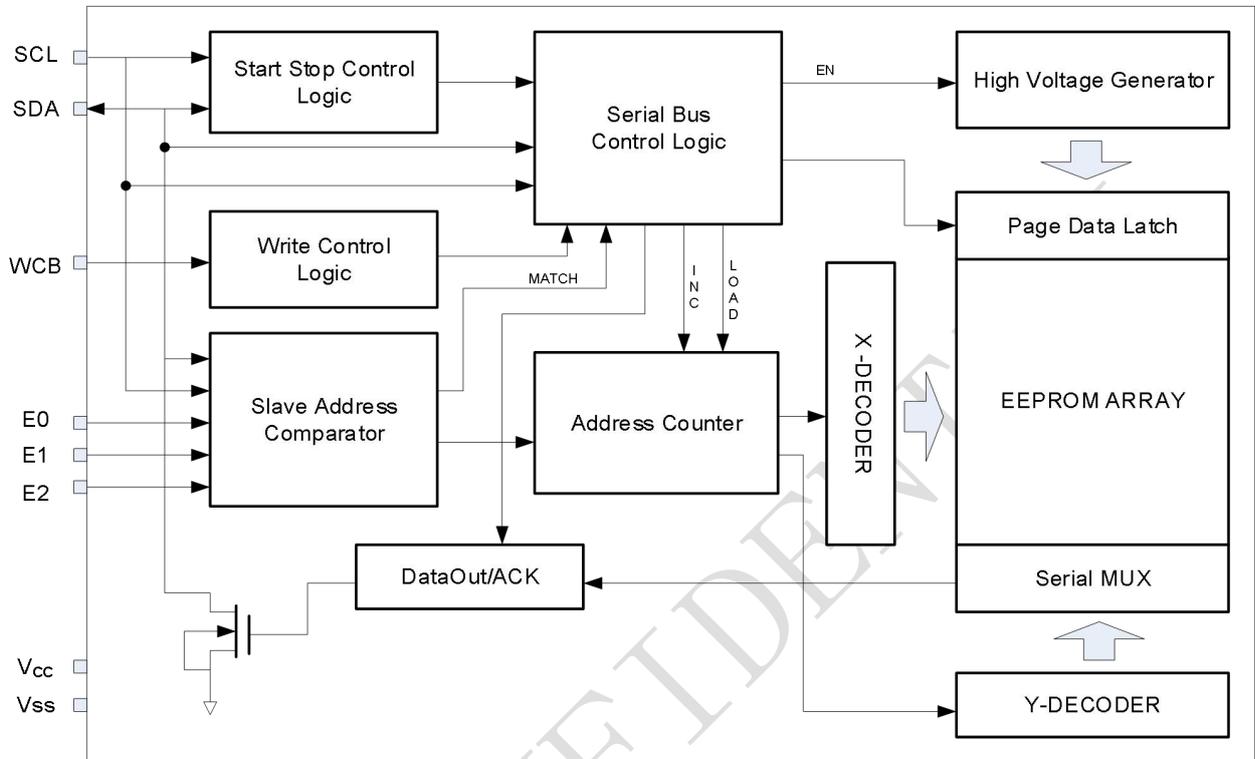
**Ground ( $V_{ss}$ ):**  $V_{ss}$  is the reference for the  $V_{cc}$  supply voltage.

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## 2. Block Diagram

Figure 2-1 Block Diagram



### 3. Electrical Characteristics

**Table 3-1 Absolute Maximum Ratings** <sup>[1]</sup>

Symbol	Parameter	Min.	Max.	Units
T <sub>STG</sub>	Storage Temperature	-65	150	°C
T <sub>A</sub>	Ambient operating temperature	-40	125	°C
V <sub>CC</sub>	Supply Voltage	-0.5	6.5	V
V <sub>IO</sub>	Input or output range	-0.5	6.5	V
I <sub>OL</sub>	DC output current (SDA=0)	-	5	mA

Note: [1] Stresses above those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

**Table 3-2 Pin Capacitance** <sup>[1]</sup>

Symbol	Parameter	Max.	Units	Test Condition
C <sub>I/O</sub>	Input / Output Capacitance (SDA)	8	pF	V <sub>I/O</sub> = V <sub>SS</sub>
C <sub>IN</sub>	Input Capacitance (E0, E1,E2,WCB,SCL)	6	pF	V <sub>IN</sub> = V <sub>SS</sub>

Note: [1] Test Conditions: T<sub>A</sub> = 25°C, f<sub>SCL</sub> = 1MHz, V<sub>CC</sub> = 5.0V.

**Table 3-3DC Characteristics** (Unless otherwise specified, V<sub>CC</sub> = 1.7V to 5.5V, T<sub>A</sub> = -40°C to 125°C)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Condition
V <sub>CC</sub>	Supply Voltage	1.7	-	5.5	V	
		1.8	-	5.5	V	
		2.5	-	5.5	V	
I <sub>sb</sub>	Standby Current	-	-	1.0	μA	V <sub>CC</sub> = 3.3V, T <sub>A</sub> = 85°C
		-	-	2.0	μA	V <sub>CC</sub> = 5.5V, T <sub>A</sub> = 85°C
		-	-	3.0	μA	V <sub>CC</sub> = 5.5V, T <sub>A</sub> = 105°C
I <sub>CC1</sub>	Supply Current(Read)	-	0.2	0.4	mA	V <sub>CC</sub> =5.5V, f <sub>SCL</sub> = 400KHz
I <sub>CC2</sub>	Supply Current(Write)	-	0.8	1.6	mA	V <sub>CC</sub> =5.5V, f <sub>SCL</sub> = 400KHz
I <sub>LI</sub>	Input Leakage Current	-	0.10	1.0	μA	V <sub>IN</sub> = V <sub>CC</sub> or V <sub>SS</sub>
I <sub>LO</sub>	Output Leakage Current	-	0.05	1.0	μA	V <sub>OUT</sub> = V <sub>CC</sub> or V <sub>SS</sub>
V <sub>IL</sub>	Input Low Level	-0.5	-	0.3V <sub>CC</sub>	V	
V <sub>IH</sub>	Input High Level	0.7V <sub>CC</sub>	-	V <sub>CC</sub> +0.5	V	
V <sub>OL1</sub>	Output Low Level V <sub>CC</sub> = 1.7V (SDA)	-	-	0.2	V	I <sub>OL</sub> = 0.15 mA
V <sub>OL2</sub>	Output Low Level V <sub>CC</sub> = 3.0V (SDA)	-	-	0.4	V	I <sub>OL</sub> = 2.1 mA

**Table 3-4 AC Characteristics** ( Unless otherwise specified,  $V_{CC} = 1.7V$  to  $5.5V$ ,  $T_A = -40^{\circ}C$  to  $125^{\circ}C$ ,  $C_L = 100pF$ , Test Conditions are listed in Notes [2] )

Symbol	Parameter	$1.7 \leq V_{CC} \leq 5.5$			$1.7 \leq V_{CC} \leq 5.5$			Units
		Min.	Typ.	Max.	Min.	Typ.	Max.	
$f_{SCL}$	Clock Frequency, SCL	-	-	400	-	-	1000	kHz
$t_{LOW}$	Clock Pulse Width Low	1.3	-	-	0.4	-	-	$\mu s$
$t_{HIGH}$	Clock Pulse Width High	0.6	-	-	0.4	-	-	$\mu s$
$t_{AA}$	Clock Low to Data Out Valid	0.05	-	0.9	0.05	-	0.55	$\mu s$
$t_i$	Noise Suppression Time	-	-	0.1	-	-	0.05	$\mu s$
$t_{BUF}$	Time the bus must be free before a new transmission can start	1.3	-	-	0.5	-	-	$\mu s$
$t_{HD.STA}$	START Hold Time	0.6	-	-	0.25	-	-	$\mu s$
$t_{SU.STA}$	START Setup Time	0.6	-	-	0.25	-	-	$\mu s$
$t_{HD.DAT}$	Data In Hold Time	0	-	-	0	-	-	$\mu s$
$t_{SU.DAT}$	Data In Setup Time	0.1	-	-	0.1	-	-	$\mu s$
$t_R$	Inputs Rise Time <sup>[1]</sup>	-	-	0.3	-	-	0.1	$\mu s$
$t_F$	Inputs Fall Time <sup>[1]</sup>	-	-	0.3	-	-	0.1	$\mu s$
$t_{SU.STO}$	STOP Setup Time	0.6	-	-	0.25	-	-	$\mu s$
$t_{DH}$	Data Out Hold Time	0.05	-	-	0.05	-	-	$\mu s$
$t_{SU.WCB}$	WCB pin Setup Time	1.2	-	-	0.6	-	-	$\mu s$
$t_{HD.WCB}$	WCB pin Hold Time	1.2	-	-	0.6	-	-	$\mu s$
$t_{WR}$	Write Cycle Time	-	-	5	-	-	5	ms

Notes: [1] This parameter is ensured by characterization not 100% tested

[2] AC measurement conditions:

- ✧  $R_L$  (connects to  $V_{CC}$ ): 1.3k $\Omega$  (2.5V, 5.5V), 10k $\Omega$  (1.7V)
- ✧ Input pulse voltages: 0.3  $V_{CC}$  to 0.7  $V_{CC}$
- ✧ Input rise and fall times:  $\leq 50ns$
- ✧ Input and output timing reference voltages: 0.5 $V_{CC}$

**Table 3-5 Reliability Characteristics** <sup>[1]</sup>

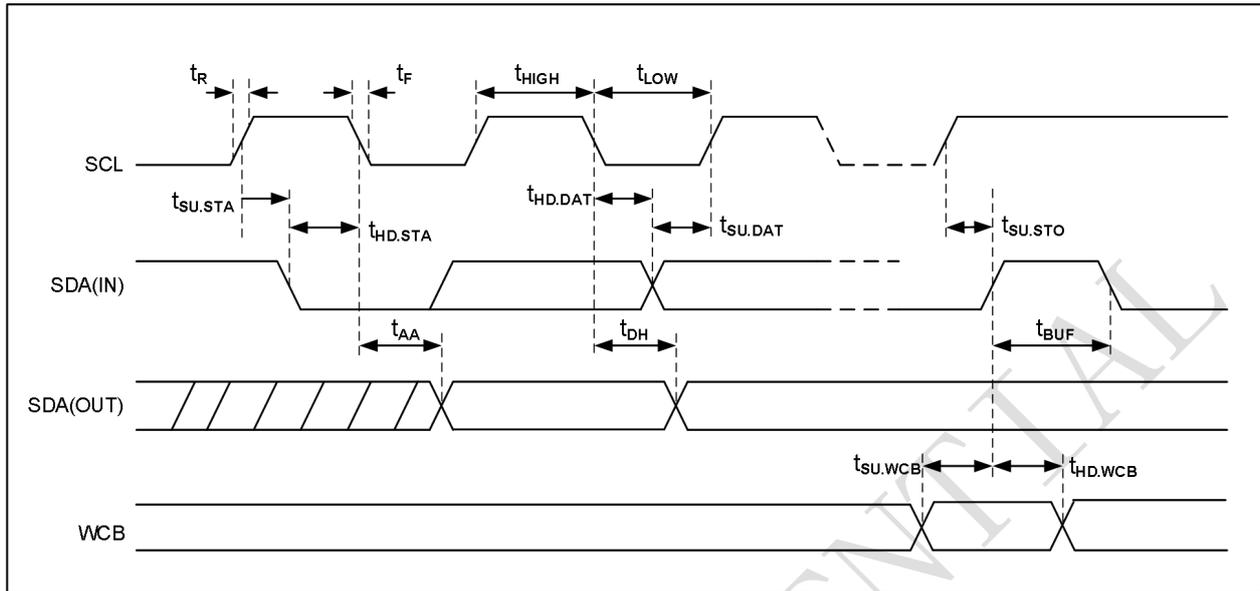
Symbol	Parameter	Min.	Typ.	Max.	Unit
<b>EDR</b> <sup>[2]</sup>	Endurance	1,000,000			Write cycles
<b>DRET</b> <sup>[3]</sup>	Data retention	100			Years

Note: [1] This parameter is ensured by characterization and is not 100% tested

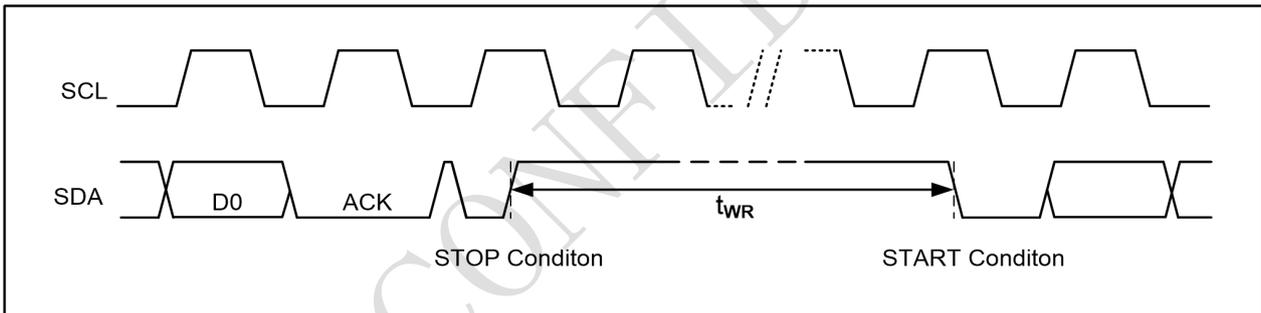
[2] Under the condition: 25 $^{\circ}C$ , 3.3V, Page mode

[3] Test condition:  $T_A = 55^{\circ}C$

**Figure 3-1 Bus Timing**



**Figure 3-2 Write Cycle Timing**



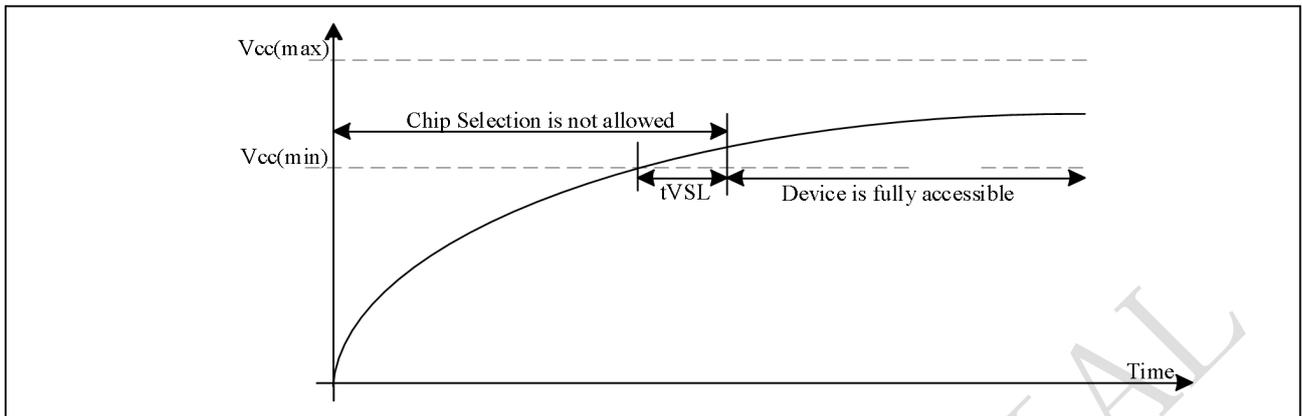
Note: [1] The write cycle time  $t_{WR}$  is the time from a valid STOP condition of a write sequence to the end of the internal clear/write cycle.

**Device Power-Up**

The EEPROM has a built-in power-on-reset circuit that initializes itself at the same time during power-on. Unsuccessful initialization may cause a malfunction. To operate the power-on-reset circuit normally, the following conditions must be satisfied to raise the power supply voltage.

When initialization is successfully completed by the power-on-reset circuit, the EEPROM enters the standby status.  $t_{VSL}$  is the time required to initialize the EEPROM. No instructions are accepted during this time.

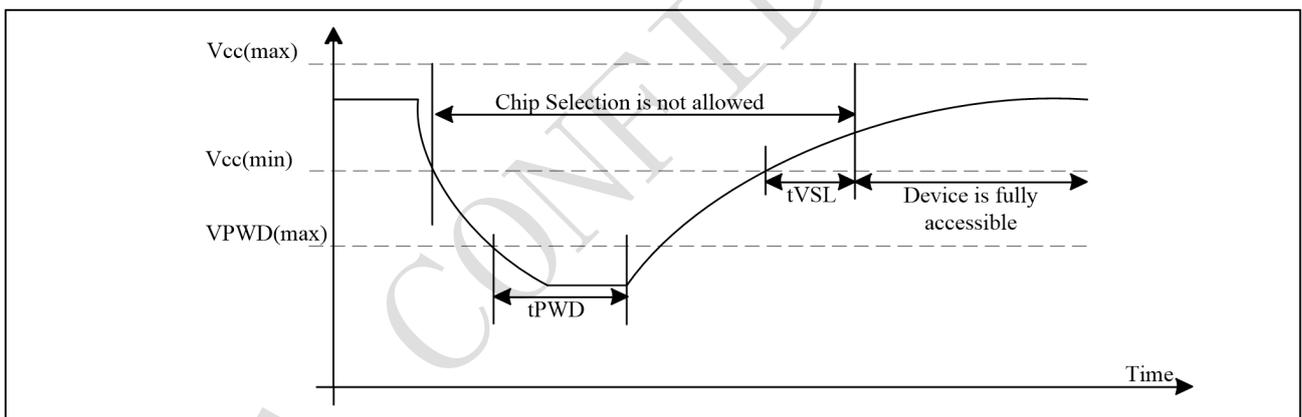
**Figure 3-3 Power up Timing**



**Power Up/Down and Voltage Drop**

For Power-down to Power-up operation, the Vcc of EEPROM device must be below VPWD for at least tPWD timing. Please check the table below for more detail.

**Figure 3-4 Power down-up Timing**



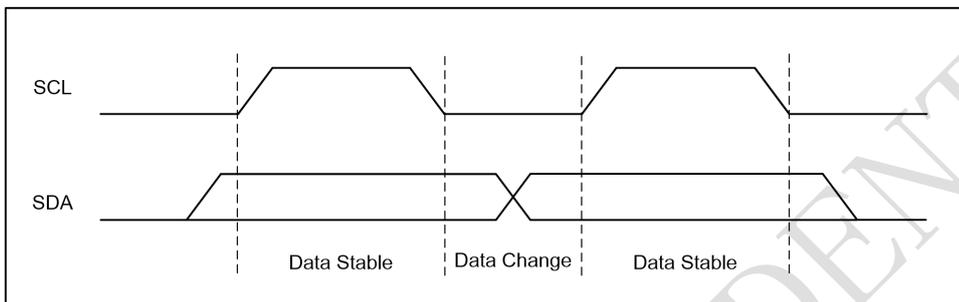
Symbol	Parameter	min	max	unit
VPWD	Vcc voltage needed to be below VPWD for ensuring initialization will occur		0.7	V
tPWD	The minimum duration for ensuring initialization will occur	300		us
tVSL	Vcc(min.) to device operation	70		us
tVR	Vcc Rise Time	1	500000	us/V

## 4. Device Operation

### 4.1 Data Input

The SDA pin is normally pulled high with an external device. Data on the SDA pin may change only during SCL low period (Refer to Figure 4-1). Data changes during SCL high period will indicate a START or STOP condition as defined below.

**Figure 4-1 Data Validity**



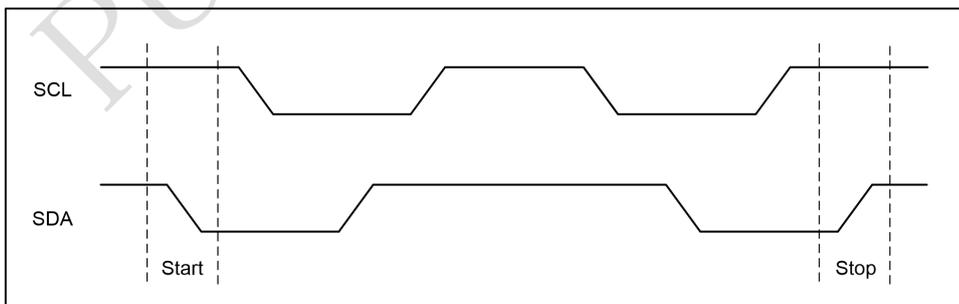
### 4.2 START Condition

A high-to-low transition of SDA with SCL high is a START condition which must precede any other command bits. (Refer to Figure 4-2).

### 4.3 STOP Condition

A low-to-high transition of SDA with SCL high is a STOP condition. After a read sequence, the STOP bit will place the P24C128D in a standby mode (Refer to Figure 4-2).

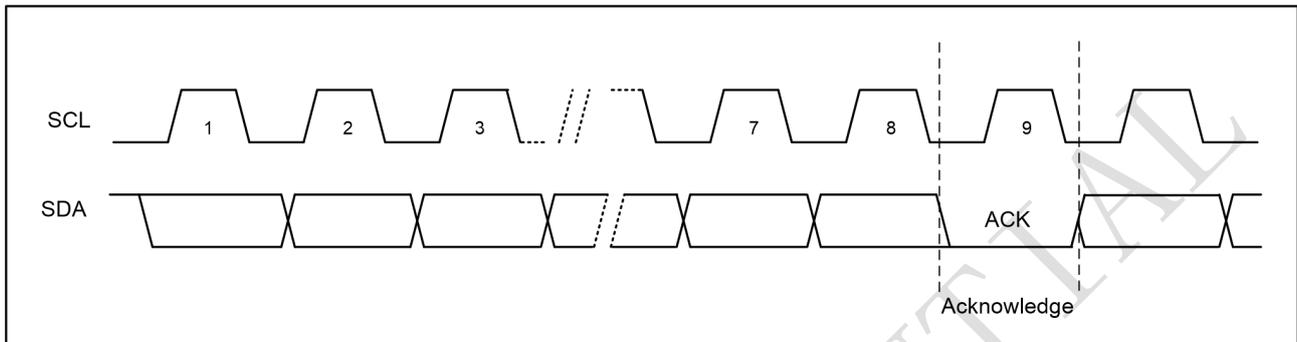
**Figure 4-2 START and STOP Definition**



### 4.4 Acknowledge (ACK)

All addresses and data are serially transmitted to and from the P24C128D in 8-bit data. The P24C128D sends a “0” to acknowledge that it has received each data. This happens during the ninth clock cycle.

**Figure 4-3 Acknowledge Bit Definition**



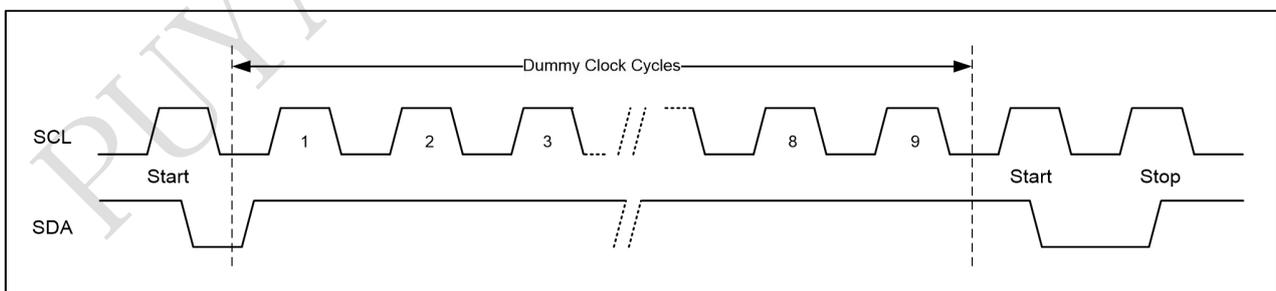
### 4.5 Standby Mode

The P24C128D features a low-power standby mode which is enabled: (a) after a fresh power up, (b) after receiving a STOP bit in read mode, and (c) after completing a self-time internal programming operation.

### 4.6 Soft Reset

After an interruption in protocol, power loss or system reset, the device can be reset by following steps: (a) Create a START condition, (b) Clock in nine data bits “1”, and (c) create another START bit followed by STOP bit condition, as shown below. The device is ready for the next communication after the above steps have been completed.

**Figure 4-4 Soft Reset**



## 4.7 Device Addressing

The P24C128D requires an 8-bit device address following a START condition to enable the chip for a read or write operation (Refer to table below). The device address consists of a mandatory one-zero sequence for the first four most-significant bits, as shown.

**Table 4-1 Device Address**

Chip	Access area	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
P24C128D	Normal Area	1	0	1	0	E2	E1	E0	R/W
	ID Page	1	0	1	1	E2	E1	E0	R/W
	Lock Bit	1	0	1	1	E2	E1	E0	R/W
	Serial Number	1	0	1	1	E2	E1	E0	1

**Table 4-2 Word Address0**

Chip	Data	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
P24C128D	Normal Area	X	X	A13	A12	A11	A10	A9	A8
	ID Page	X	X	X	X	0	0	X	X
	Lock Bit	X	X	X	X	X	1	X	X
	Serial Number	X	X	X	X	1	0	X	X

**Table 4-3 Word Address1**

Chip	Data	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
P24C128D	Normal Area	A7	A6	A5	A4	A3	A2	A1	A0
	ID Page	X	X	A5	A4	A3	A2	A1	A0
	Lock Bit	X	X	X	X	X	X	X	X
	Serial Number	X	X	X	X	A3	A2	A1	A0

The E2, E1 and E0 bits allow as many as eight devices on the same bus. These bits must compare to their corresponding hardwired input pins. The E2, E1 and E0 pins use an internal proprietary circuit that biases them to a logic low condition if the pins are floating. The bit0 of the device address is the read/write operation select bit. A read operation is initiated if this bit is high and a write operation is initiated if this bit is low. Upon a matched comparison result, the Chip will output a zero. If not, the device will return to a standby state.

## 4.8 Data Security

P24C128D has a hardware data protection scheme that allows the user to write protect the whole memory when the WCB pin is high.



### 5.1.3 Acknowledge Polling

Once the internally timed write cycle has started, the P24C128D inputs are disabled and acknowledge polling can be initiated. This involves sending a START condition followed by the device address. The read/write bit is representative of the operation desired. Until the internal write cycle has completed will the device respond “0”, allowing the read or write sequence to continue.

### 5.1.4 Write Identification Page

The Identification Page (64 bytes) is an additional page which can be written and (later) permanently locked in Read-only mode. It is written by the Write Identification Page instruction. This instruction uses the same protocol and format as Page Write (into memory array), except for the following differences:

- Device type identifier = 1011b
- Address bits A11~A10 must be ‘00’.
- Address bits A5~A0 define the byte address inside the Identification page.
- Other Address bits are don’t care.

If the Identification page is locked, the data bytes transferred during the Write Identification Page instruction are not acknowledged (NoACK).

### 5.1.5 Lock Identification Page

The Lock Identification Page instruction (Lock ID) permanently locks the Identification page in Read-only mode. The Lock ID instruction is similar to Byte Write (into memory array) instruction with the following specific conditions:

- Device type identifier = 1011b
- Address bit A11~A10 must be ‘01’; all other address bits are don’t care
- The data byte must be equal to the binary value xxxx xx1x, where x is don’t care

## 5.2 Read Operations

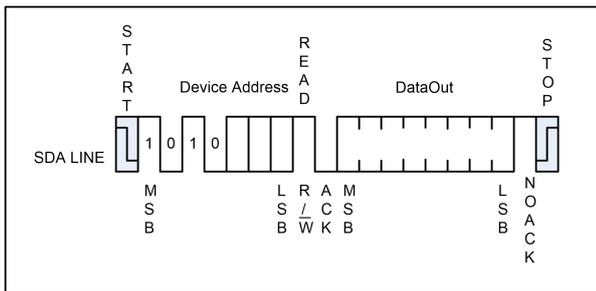
Read operations are initiated in the same way as write operations with the exception that the read/write select bit in the device address is set to “1”. There are three read operations: Current Address Read; Random Address Read and Sequential Read.

### 5.2.1 Current Address Read

The last address accessed during the last read or write operation is always incremented by one after the STOP condition of the last command. Then the Current Address Read instruction read data start from that address and increased by one after every data byte read. The address counter rolls over to the first byte of the first page if the last byte of the last memory page is encountered.

Once the device address with the read/write select bit set to “1” is clocked in and acknowledged by the device, the data at the current address is serially clocked out. The master does not respond with an input “0” but does generate a following STOP condition (Refer to Figure 5-3).

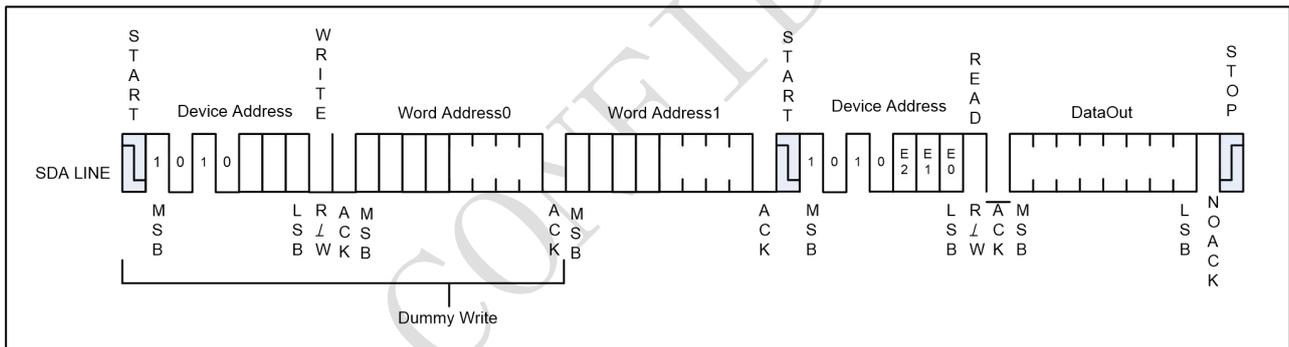
**Figure 5-3 Current Address Read**



**5.2.2 Random Read**

A Random Read requires a “dummy” byte write sequence to load in the word address. Once the device address and word address are clocked in and acknowledged by the device, the master must generate another START condition. The master now initiates a Current Address Read by sending a device address with the read/write select bit high. The device acknowledges the device address and serially clocks out the data. The master does not respond with a “0” but does generate a following STOP condition (Refer to Figure 5-4).

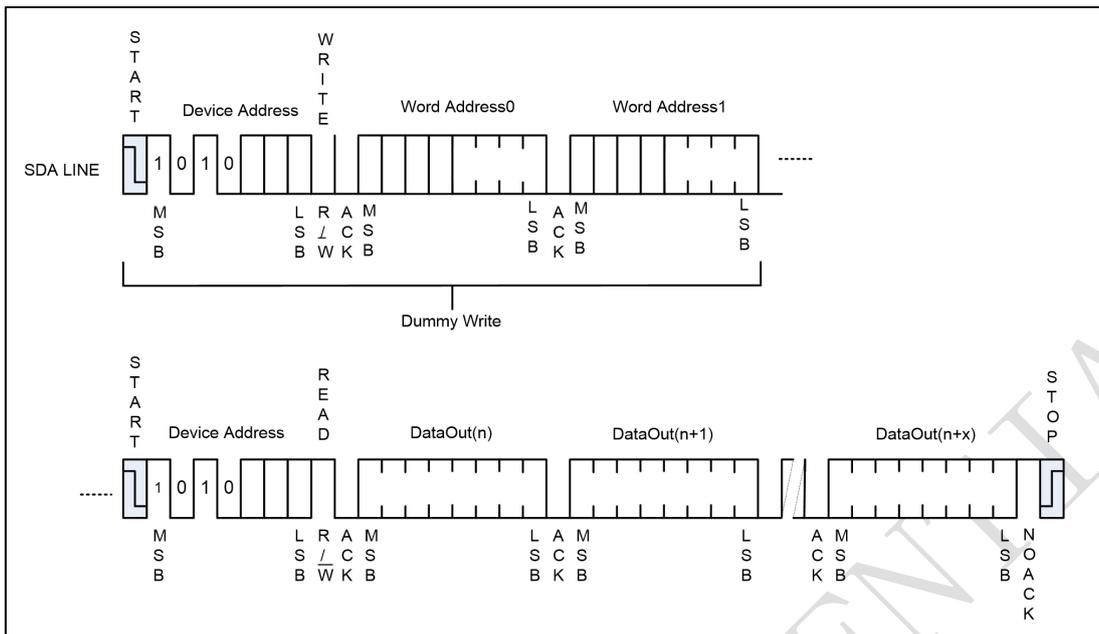
**Figure 5-4 Random Read**



**5.2.3 Sequential Read**

Sequential Reads are initiated by either a Current Address Read or a Random Address Read. After the master receives a data word, it responds with acknowledge. As long as the device receives acknowledge, it will continue to increment the word address and serially clock out sequential data. When the memory address limit is reached, the word address will roll-over and the Sequential Read will continue. The Sequential Read operation is terminated when the master does not respond with a “0” but does generate a following STOP condition (Refer to Figure 5-5)

**Figure 5-5 Sequential Read**



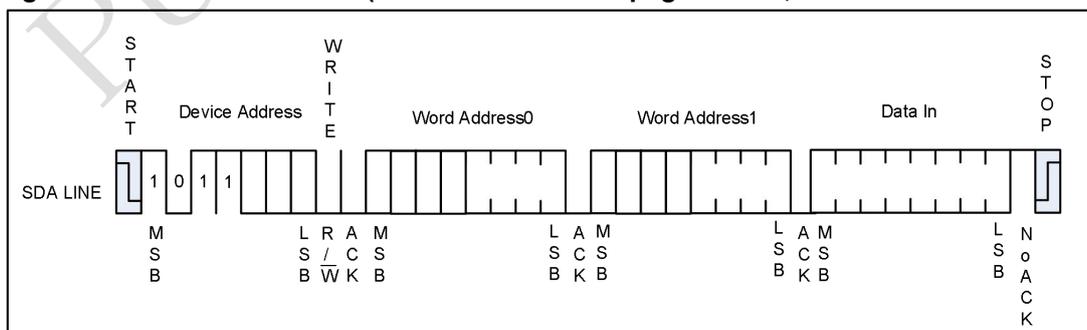
**5.2.4 Read Identification Page**

The Identification Page (64 bytes) is an additional page which can be written and (later) permanently locked in Read-only mode. The Identification Page can be read by Read Identification Page instruction which uses the same protocol and format as the Read Command (from memory array) with device type identifier defined as 1011b. The MSB address bits A11 and A10 must be 0 and the LSB address bits A5~A0 define the byte address inside the Identification Page. The number of bytes to read in the ID page must not exceed the page boundary (e.g. when reading the Identification Page from location 58d, the number of bytes should be less than or equal to 6, as the ID page boundary is 64 bytes).

**5.2.5 Read the Lock Status**

The locked/unlocked status of the Identification page can be checked by transmitting a specific truncated command [Identification Page Write instruction + one data byte] to the device. The device returns an acknowledge bit if the Identification page is unlocked, otherwise a No-ACK bit if the Identification page is locked. (Refer to Figure 5-6).

**Figure 5-6 Lock Status Read (When Identification page locked, return No-ACK after the data-in)**



### 5.2.6 Read Serial Number

Reading the serial number is similar to the sequential read sequence but requires use of the device address refer to Table 4-1, a dummy write, and the use of a specific word address. The entire 128 bits value must be read from the starting address of the serial number block to guarantee a unique number.

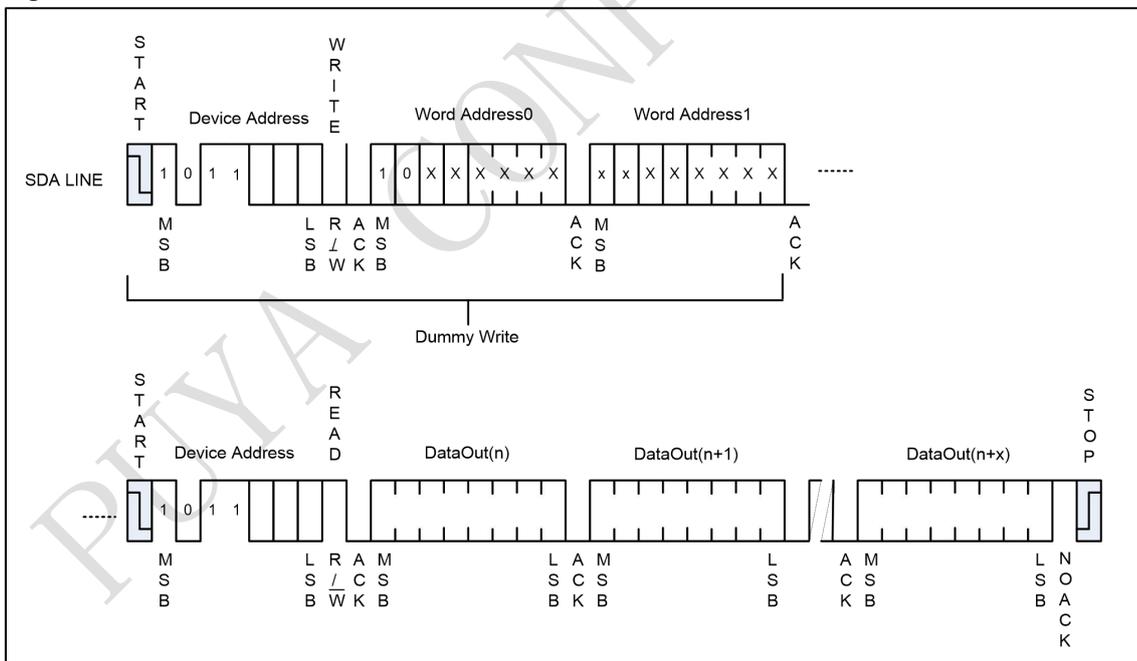
Since the address pointer of the device is shared between the regular EEPROM array and the serial number block, a dummy write sequence, as part of a Random Read or Sequential Read protocol, should be performed to ensure the address pointer is set to zero. A Current Address Read of the serial number block is supported but if the previous operation was to the EEPROM array, the address pointer will retain the last location accessed, incremented by one. Reading the serial number from a location other than the first address of the block will not result in a unique serial number.

Additionally, the word address contains a '10' sequence in bit A11 and A10 of the word address, regardless of the intended address as depicted in Table 4-2. If a word address other than '10' is used, then the device will output undefined data.

Example: If the application desires to read the first byte of the serial number, the word address input would need to be 0800h.

The Serial Number Read operation is terminated when the master does not respond with a zero (ACK) and instead issues a STOP bit (Refer to Figure 5-7)

**Figure 5-7 Serial number Read**



## 6. Ordering Code Detail

Example:

P 2 4 C 128 D - S S H - M I T

**Company Designator**

P = Puya Semiconductor

**Product Series Name**

24C = I2C-compatible Interface EEPROM

**Device Density**

128 = 128K bits

**Device Version**

D = Version D

**Package Option**

DP: PDIP8	SS: SOP8(150mil)
TS: TSSOP8	MS: MSOP8
DN: DFN8	UN: UDFN8
ST: SOT23-5	TO: TSOT23-5
WF: WAFER	

**Plating Technology**

H: RoHS Compliant, Halogen-free, Antimony-free

**Operation Voltage**

M: 1.7~5.5V  
 N: 1.8~5.5V  
 D: 2.5~5.5V

**Device Grade**

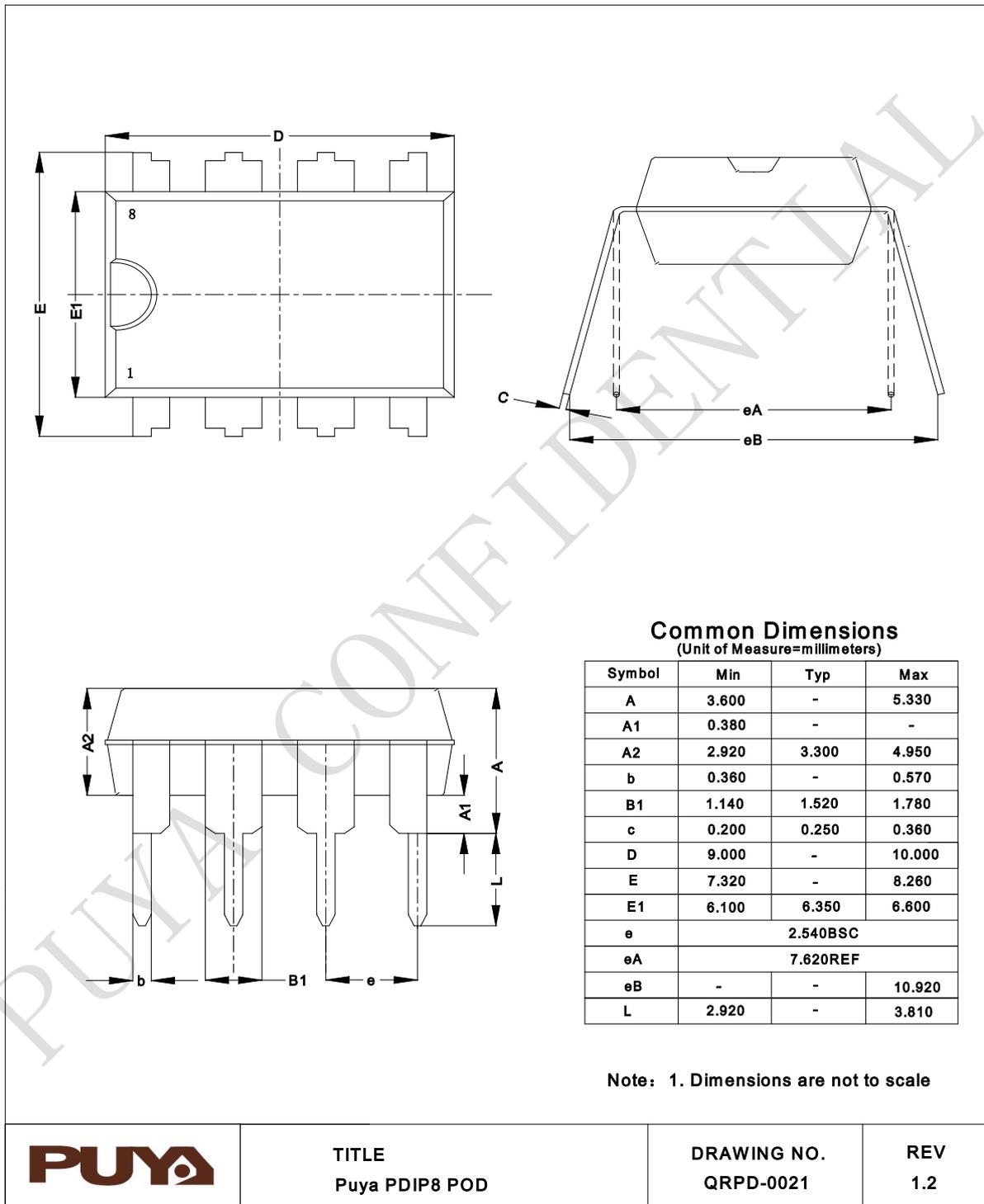
I: -40~85C  
 K: -40~105C  
 E: -40~125C

**Shipping Carrier Option**

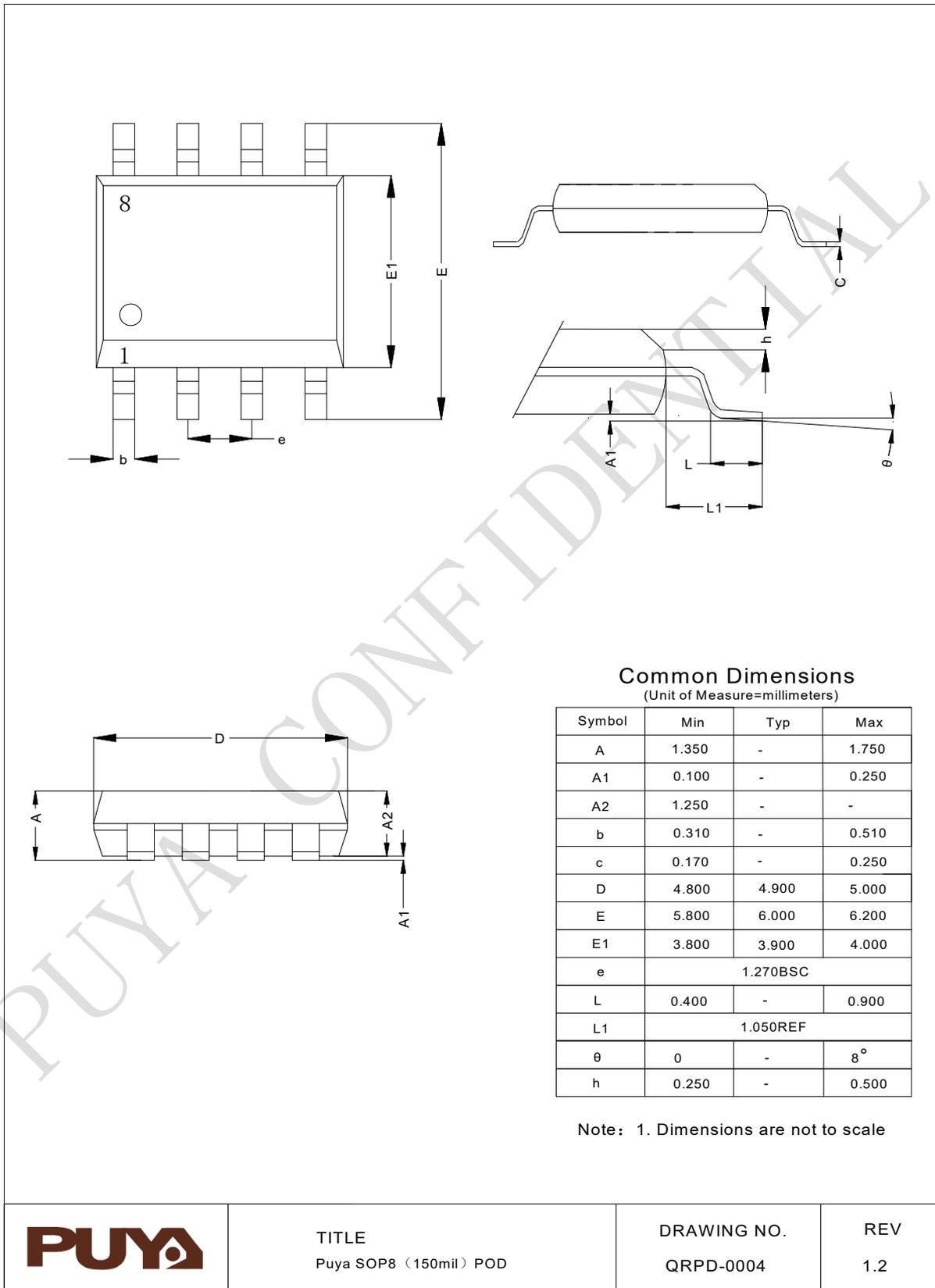
W: WAFER  
 T: TUBE  
 R: TAPE & REEL

## 7. Package information

### 7.1 PDIP8



7.2 SOP8(150mil)

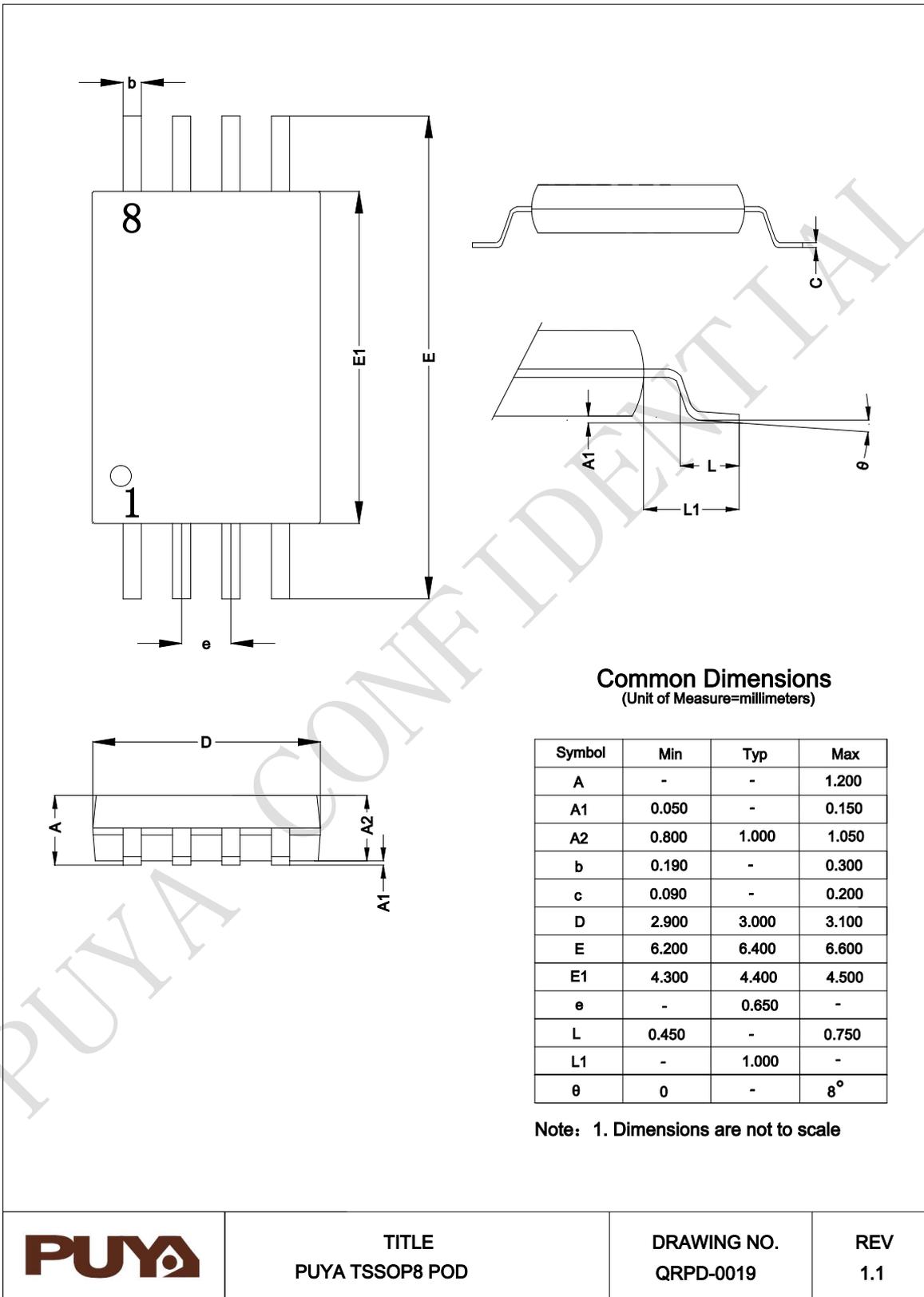


TITLE  
Puya SOP8 (150mil) POD

DRAWING NO.  
QRPD-0004

REV  
1.2

7.3 TSSOP8

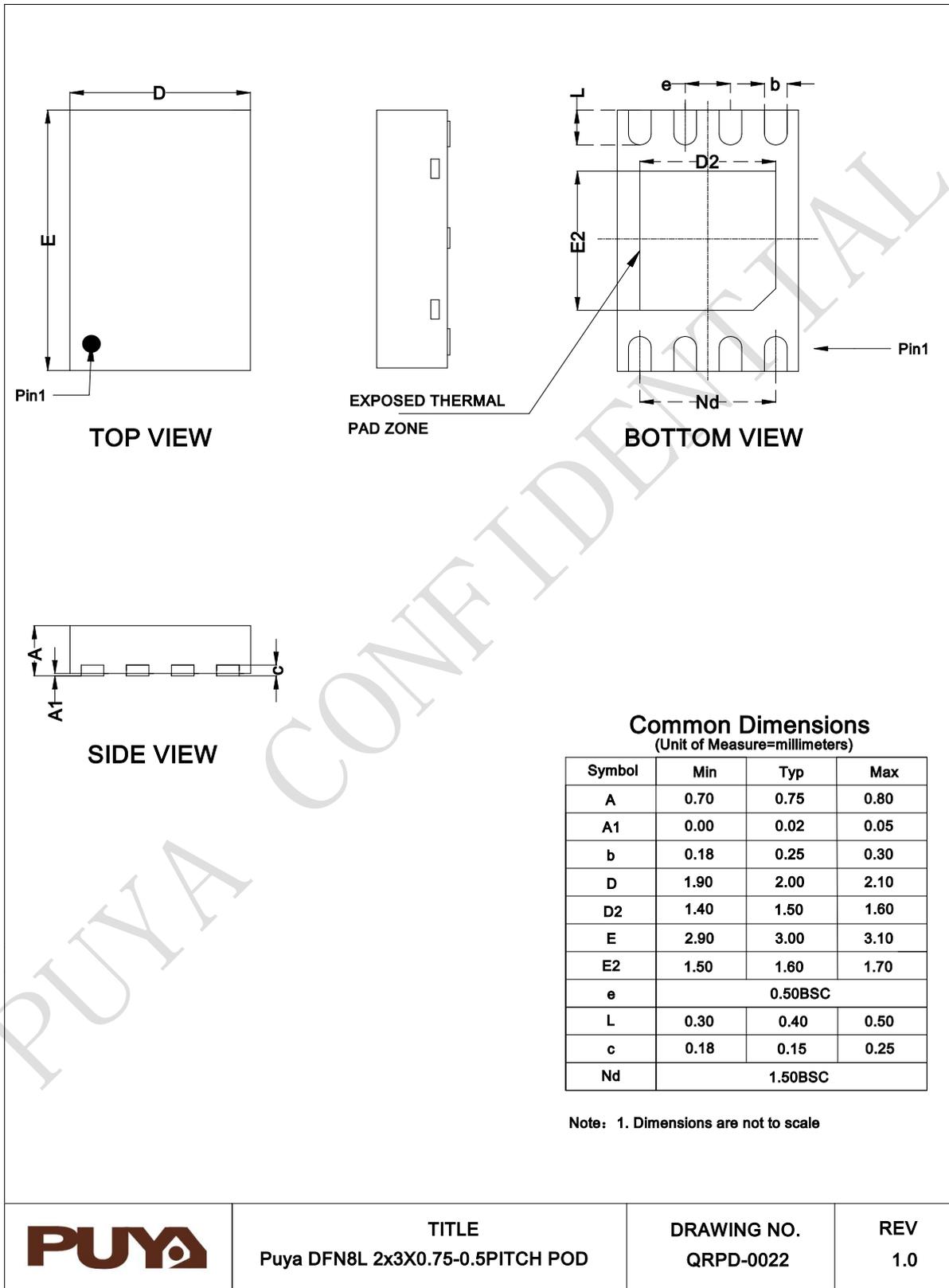


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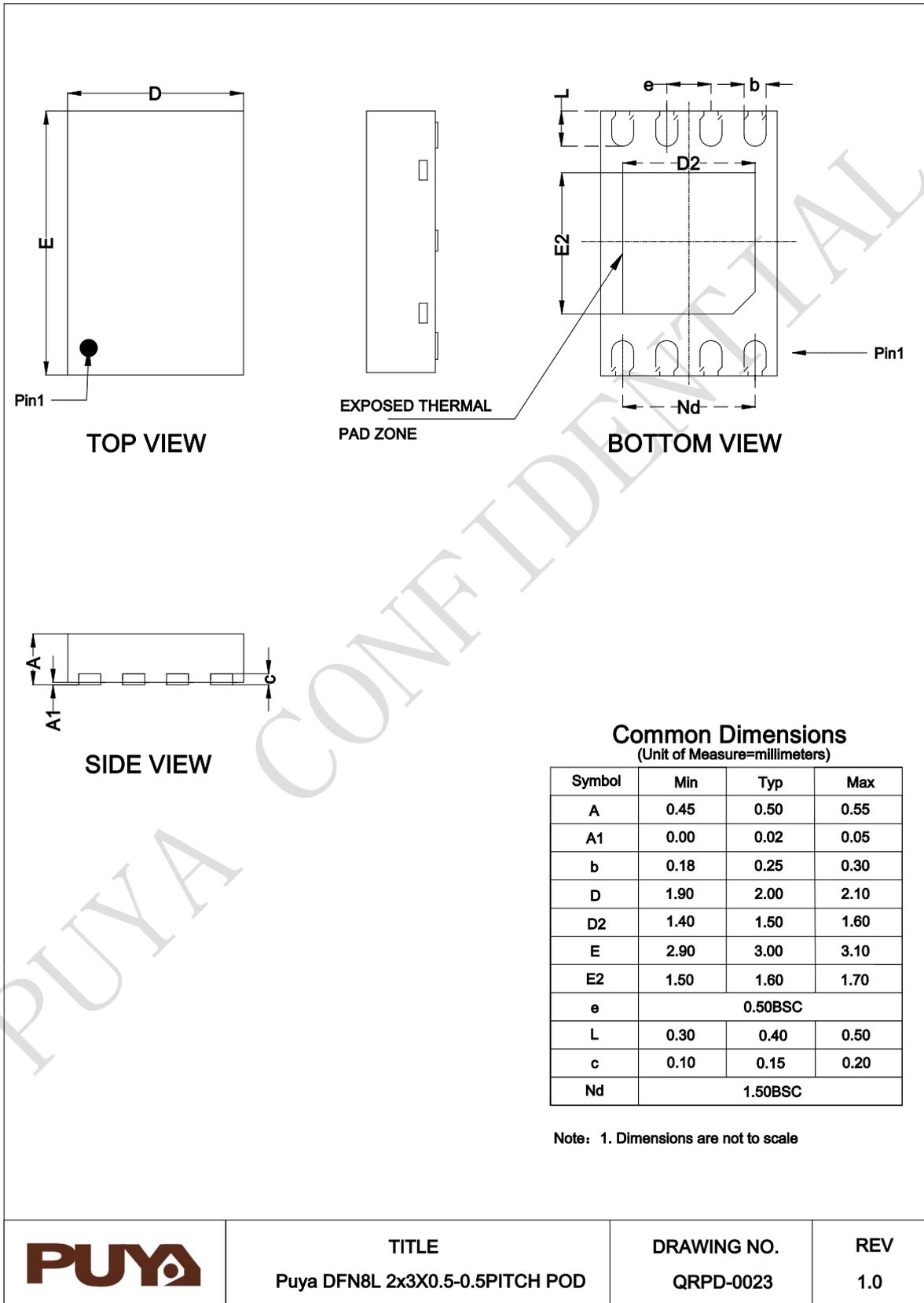
DRAWING NO.  
QRPD-0019

REV  
1.1

7.4 DFN8

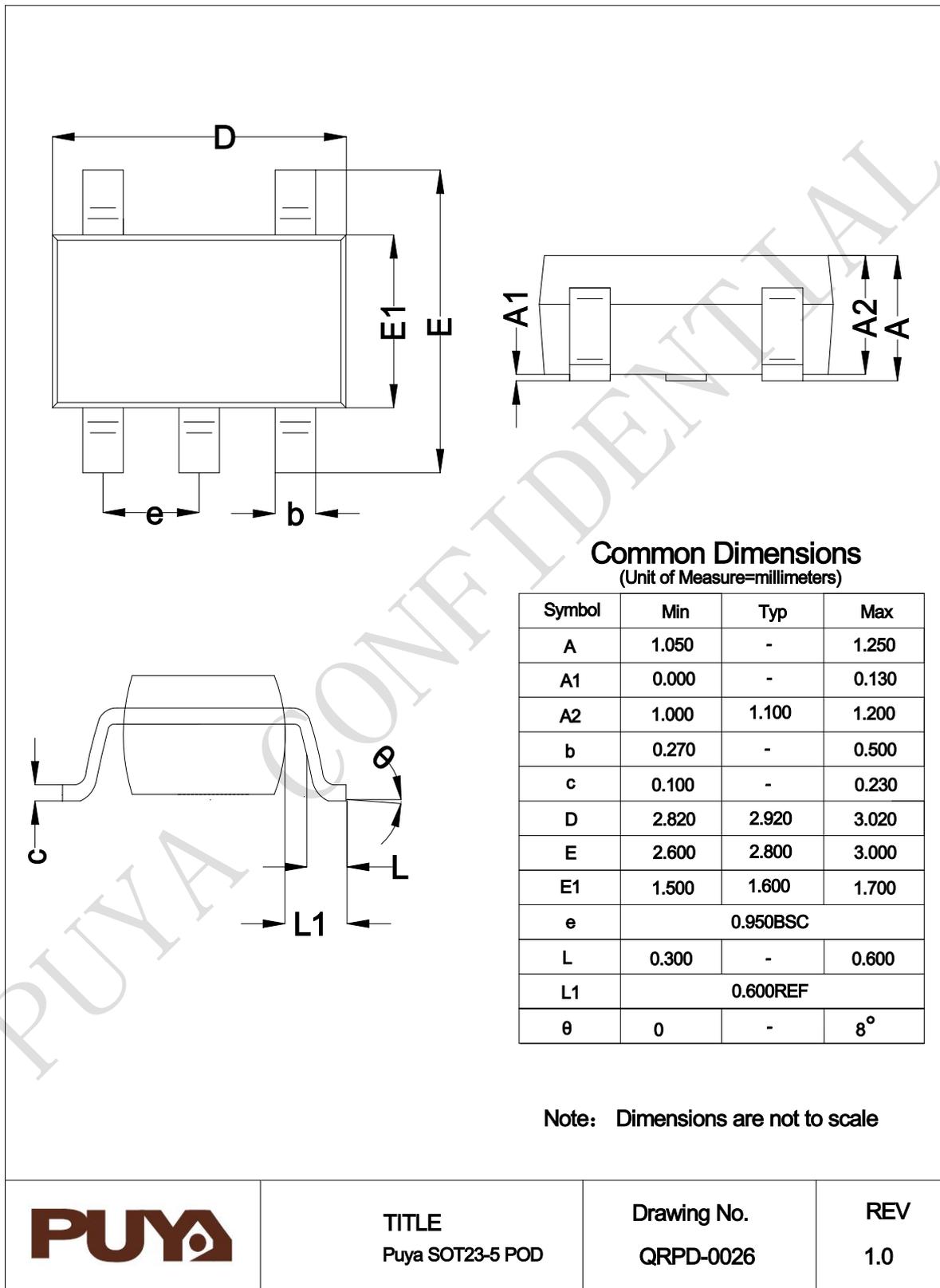


7.5 UDFN8

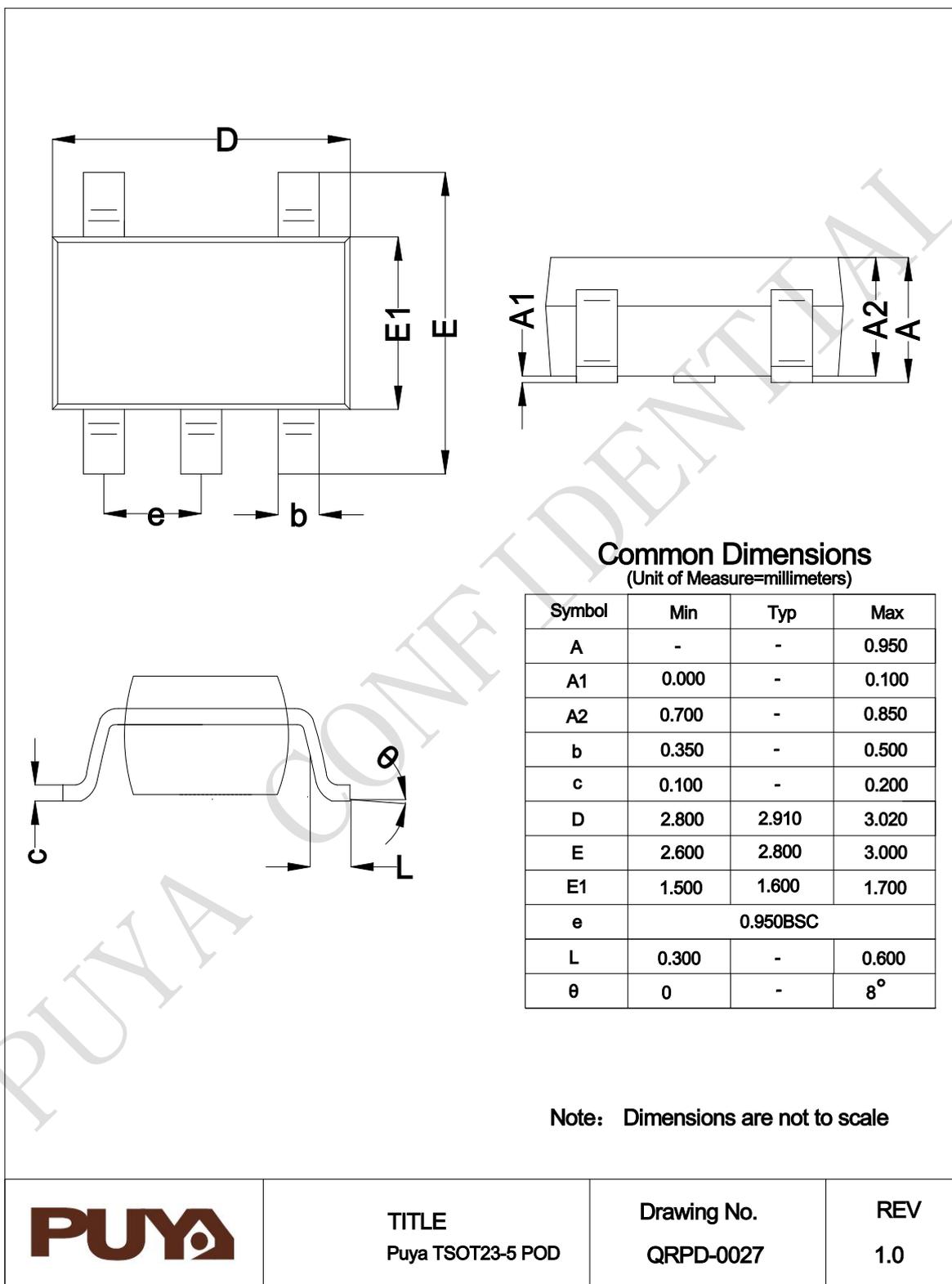


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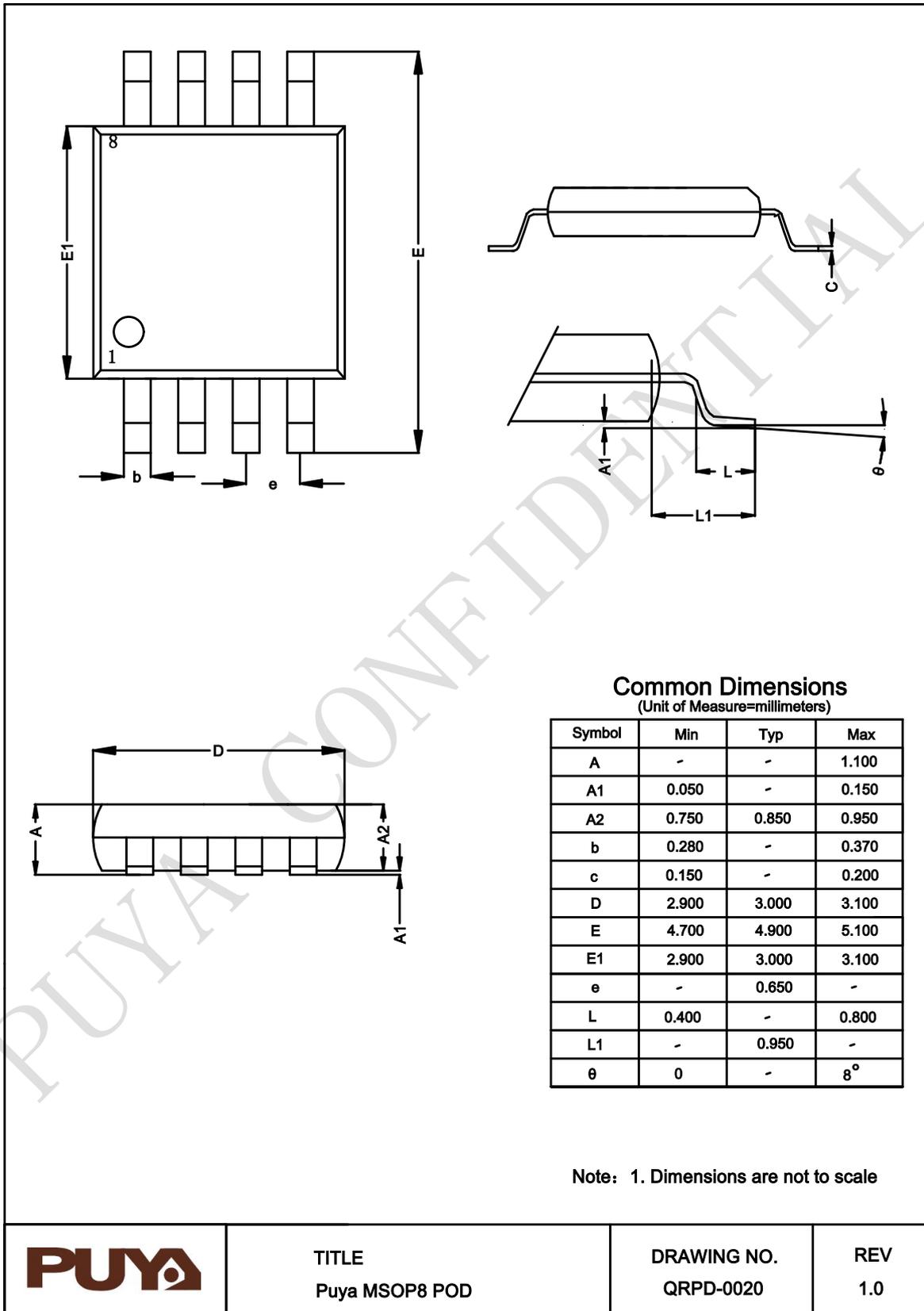
7.6 SOT23-5



7.7 TSOT23-5



7.8 MSOP8



## 8. Revision History

Version	Content	Date
V1.0	Initial Release	2016-11-11
V1.1	Remove WLCSP Package	2016-12-01
V1.2	(1) Correct command waveform from one byte word address to two bytes word address. (2) Correct the descriptions for read and write instruction (3) Add Rpd in DC characteristics	2017-03-08
V1.3	Add package MSOP-8	2019-04-17
V1.4	Modify Table3-3 (1) Correct Condition 1.7V~2.25V to 1.7V~5.5V (2) Correct $t_R$ under 2.5V~5.5V with 1000Khz from 0.3us to 0.1us	2020-11-04
V1.5	Update Package Information	2022-03-04
V1.6	Update parameter of $V_{IL}$	2023-03-26
V1.7	(1) Update Features (2) Update $I_{CC1}$ and $I_{CC2}$ of DC Characteristics (3) Update PDIP8 POD (4) Update SOP8(150mil) POD (5) Update TSSOP8 POD (6) Update SOT23-5 POD (7) Update TSOT23-5 POD	2025-06-16



Puya Semiconductor Co., Ltd.

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